

## High Side & Low Side Gate Driver

### General Description

The ID7186 is a high voltage, high speed power MOSFET and IGBT driver with independent high and low side referenced output channels. Proprietary HVIC and latch immune CMOS technologies enable ruggedized monolithic construction. Logic inputs are compatible with standard CMOS or LSTTL outputs, down to 3.3V logic. The output drivers feature a high pulse current buffer stage designed for minimum driver cross-conduction. The floating channel can be used to drive an N-channel power MOSFET or IGBT in the high side configuration which operates up to 600V. Propagation delays are matched to simplify use in high frequency applications.

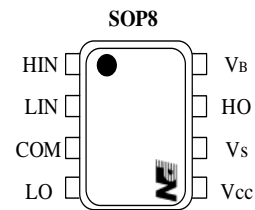
### Application

- Major home appliance
- Drives
- EV charging
- Motor inverter

### Features

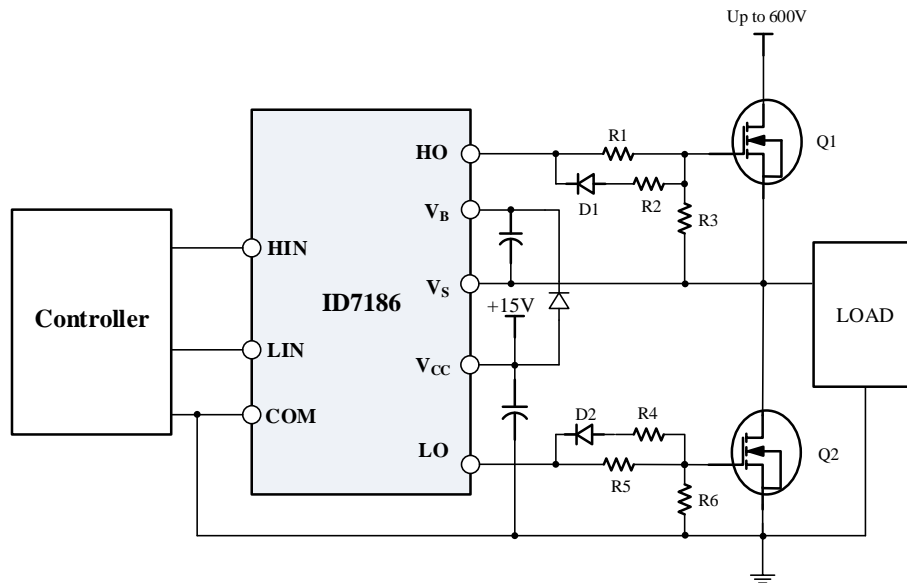
- Fully operational to +600V
- 3.3V and 5V logic compatible
- Floating channel designed for bootstrap operation
- Gate drive supply range from 10V to 20V
- Matched propagation delay for both channels
- UVLO for both channels
- Tolerant to negative transient voltage
- dV/dt immune
- 4A/4A output current capability

### Package/Order Information



Order code	Package
ID7186SEC-R1	SOP8

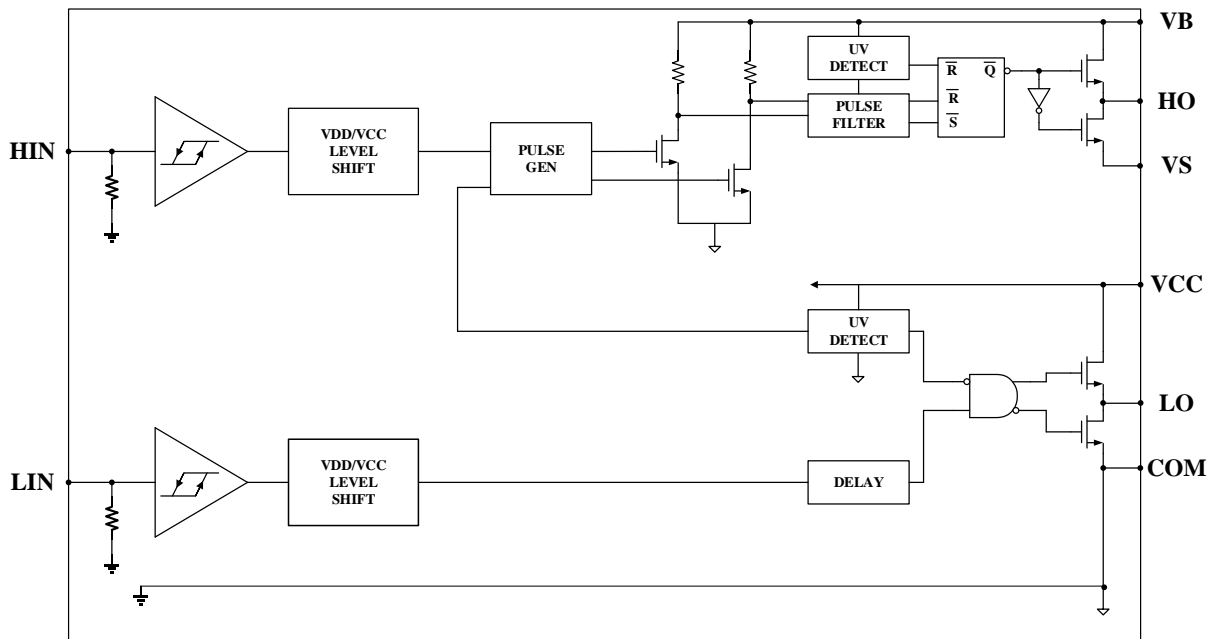
### Typical Application



## Pin Definitions

Pin Name	Pin Number	Pin Function Description
HIN	1	Logic input for high side gate driver output (HO), in phase
LIN	2	Logic input for low side gate driver output (LO), in phase
COM	3	Low side return
LO	4	Low side gate drive output
VCC	5	Low side supply
VS	6	High side floating supply return
HO	7	High side gate drive output
VB	8	High side floating supply

## Block Diagram



## Absolute Maximum Ratings

Exceeding these ratings may damage the device.

The absolute maximum ratings are stress ratings only at  $T_A=25\text{ }^\circ\text{C}$ , unless otherwise specified.

Symbol	Definition	MIN.	MAX.	Units
$V_B$	High side floating supply voltage	-0.3	620	V
$V_S$	High side floating supply offset voltage	$V_B - 20$	$V_B + 0.3$	
$V_{HO}$	High side gate drive output voltage	$V_S - 0.3$	$V_B + 0.3$	
VCC	Low side supply voltage	-0.3	20	
$V_{LO}$	Low side gate drive output voltage	-0.3	$V_{CC} + 0.3$	
$V_{IN}$	Logic input voltage (HIN, LIN)	$V_{SS} - 0.3$	$V_{CC} + 0.3$	
dVs/dt	Allowable Offset Supply Voltage Transient	--	50	V/ns
ESD	HBM Model	2	--	kV
	CDM Model	200	--	V
$P_D$	Package Power Dissipation @ $T_A \leq 25^\circ\text{C}$	--	1.25	W
$R_{thJA}$	Thermal Resistance Junction to Ambient	--	120	$^\circ\text{C}/\text{W}$
$T_J$	Junction Temperature	--	150	$^\circ\text{C}$
$T_S$	Storage Temperature	-50	150	
$T_L$	Lead Temperature (Soldering, 10 seconds)	--	300	

## Recommended Operating Conditions

Symbol	Definition	Min.	Max.	Units
$V_B$	High side floating supply absolute voltage	$V_S + 10$	$V_S + 20$	V
$V_S$	High side floating supply offset voltage	--	600	
$V_{HO}$	High side gate floating output voltage	$V_S$	$V_B$	
VCC	Low side fixed supply voltage	10	20	
$V_{LO}$	Low side output voltage	GND	VCC	
$V_{IN}$	Logic input voltage(HIN & LIN)	GND	VCC	
$T_A$	Ambient temperature	-40	125	$^\circ\text{C}$

## Dynamic Electrical Characteristics

( $V_{BIAS}$  ( $V_{CC}$ ,  $V_{BS}$ ) = 15V,  $C_L$  = 1000pF and  $T_A$  = 25 °C unless otherwise specified.)

Symbol	Definition	Test Condition	MIN.	TYP.	MAX.	Units
$t_{on\_H}$	Turn-on propagation delay(HIN to HO)	$V_S = 0V$	-	110	-	ns
$t_{off\_H}$	Turn-off propagation delay(HIN to HO)	$V_S = 600V$	-	110	-	
$t_{on\_L}$	Turn-on propagation delay(LIN to LO)	$V_S = 0V$	-	60	-	
$t_{off\_L}$	Turn-off propagation delay(LIN to LO)	$V_S = 0V$	-	60	-	
$t_r$	Turn-on rise time		-	18	-	
$t_f$	Turn-off fall time		-	12	-	
MT	Dealy matching, HS&LS turn on/off		-	-	70	

## Static Electrical Characteristics

( $V_{BIAS}$  ( $V_{CC}$ ,  $V_{BS}$ ) = 15V,  $C_L$  = 1000pF and  $T_A$  = 25 °C unless otherwise specified.)

Symbol	Definition	Test Condition	MIN.	TYP.	MAX.	Units	
$V_{IH}$	Logic “1”(HIN& LIN) input voltage		2.6	-	-	V	
$V_{IL}$	Logic “0” (HIN & LIN) input voltage		-	-	0.8		
$V_{OH}$	High level output voltage, $V_{BIAS} - V_O$		$I_O=20mA$	-	0.2		0.4
$V_{OL}$	Low level output voltage, $V_O$			-	-		0.15
$I_{QCC}$	Quiescent VCC supply current	$V_{IN} = 0V$	-	100	200	$\mu A$	
$I_{QCC}$	Quiescent VCC supply current	$V_{IN} = 5V$	-	120	240		
$I_{QBS}$	Quiescent $V_{BS}$ supply current	$V_{IN} = 0V$	-	95	190		
$I_{QBS}$	Quiescent $V_{BS}$ supply current	$V_{IN} = 5V$	-	130	240		
$I_{LK}$	Leakage current from VS(600V) to GND	$V_B = V_S = 600V$	-	-	10		
$I_{IN+}$	Logic “1” input bias current	$V_{IN} = V_{CC}$	-	25	60		
$I_{IN-}$	Logic “0” input bias current	$V_{IN} = 0V$	-	-	5		
$V_{BSU+}$	$V_{BS}$ supply UVLO threshold		8.4	9.2	10	V	
$V_{BSU-}$			7.6	8.4	9.2		
$V_{CCU+}$	VCC supply UVLO threshold		8.4	9.2	10		
$V_{CCU-}$			7.6	8.4	9.2		
$I_{O+}$	Output high short circuit pulsed current	$V_O = 0V$ , $V_{IN} = V_{CC}$ $PW \leq 10\mu s$	3.5	4	-	A	
$I_{O-}$	Output low short circuit pulsed current	$V_O = 15V$ , $V_{IN} = 0V$ $PW \leq 10\mu s$	3.5	4	-		

## Function Timing Diagram

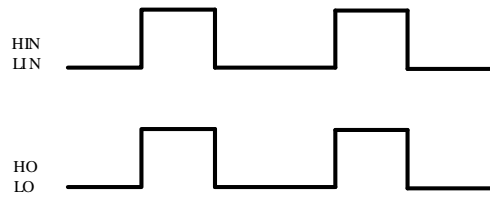


Fig.1 Input and output logic

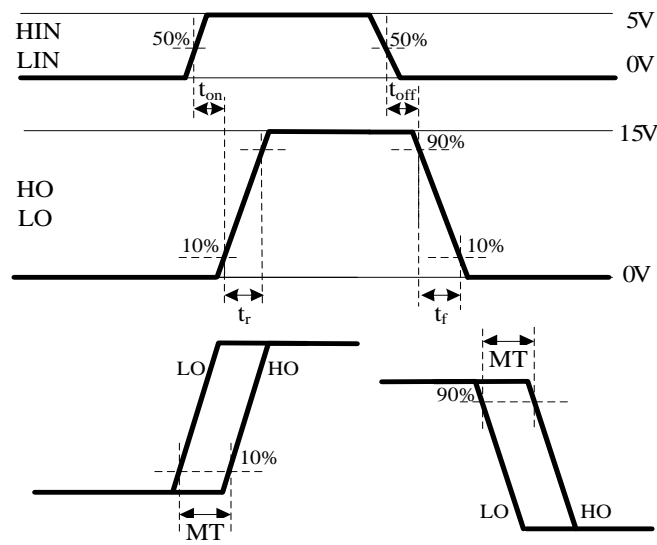


Fig.2 Propagation Delay, Rise Time, Fall Time Timing and Delay Matching

## Typical Characteristics Plots

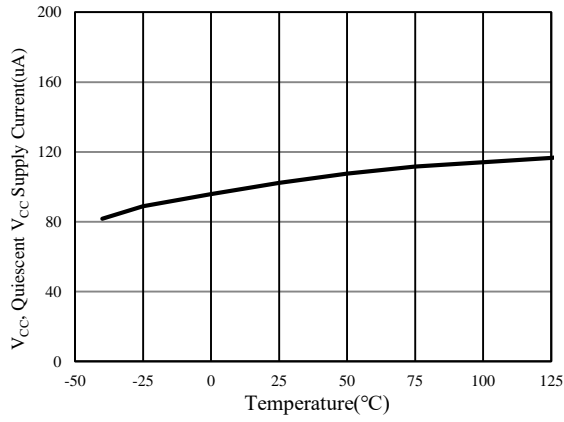


Figure 3. Quiescent V<sub>CC</sub> Supply Current vs. Temperature

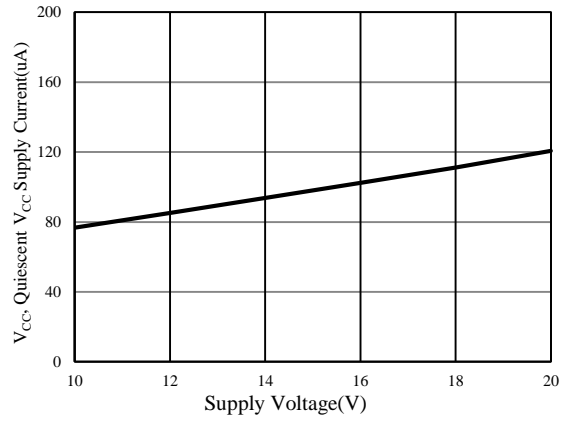


Figure 4. Quiescent V<sub>CC</sub> supply current vs. Supply Voltage

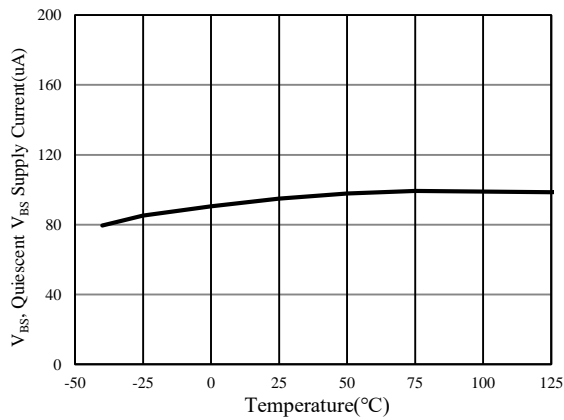


Figure 5. Quiescent V<sub>BS</sub> Supply Current vs. Temperature

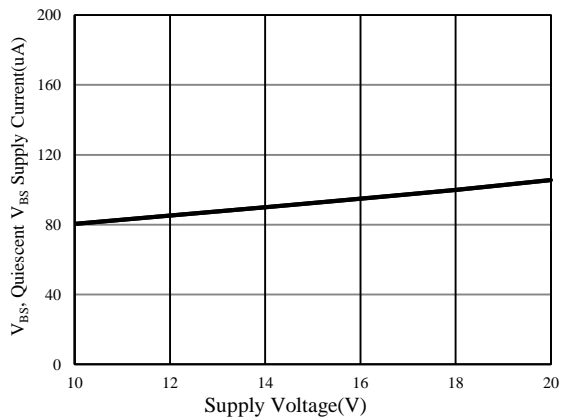


Figure 6. Quiescent V<sub>BS</sub> supply current vs. Supply Voltage

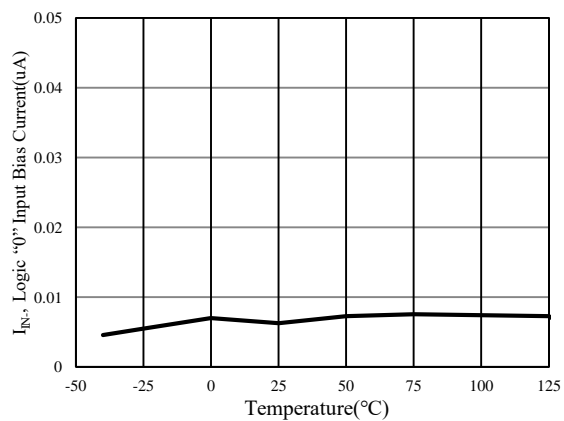


Figure 7. Logic "0" Input Bias Current vs. Temperature

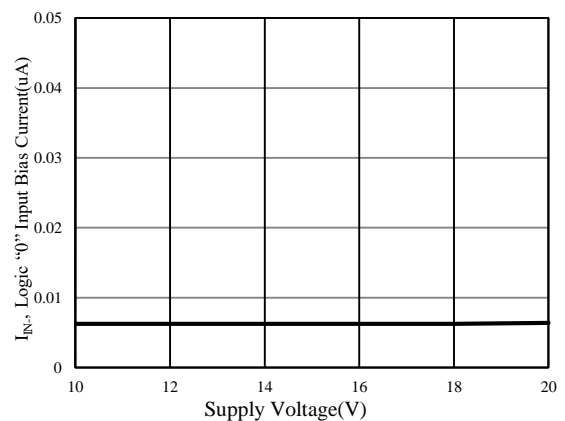


Figure 8. Logic "0" Input Bias Current vs. Supply Voltage

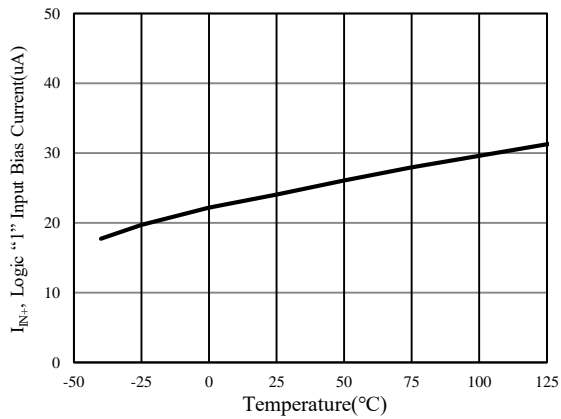


Figure 9. Logic "1" Input Bias Current vs. Temperature

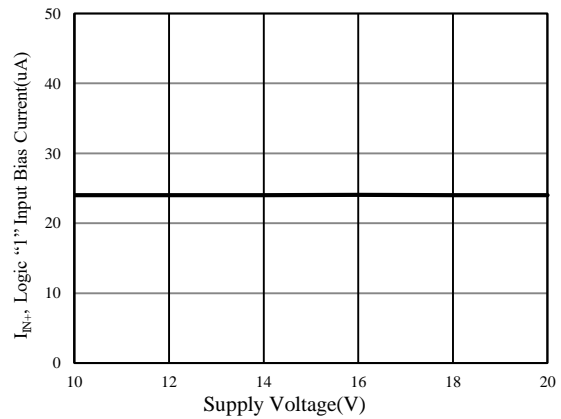


Figure 10. Logic "1" Input Bias Current vs. Supply Voltage

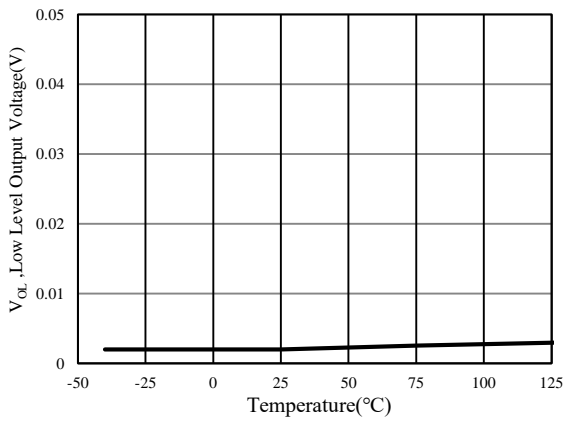


Figure 11. Low Level Output Voltage ( $I_o=2mA$ ) vs. Temperature

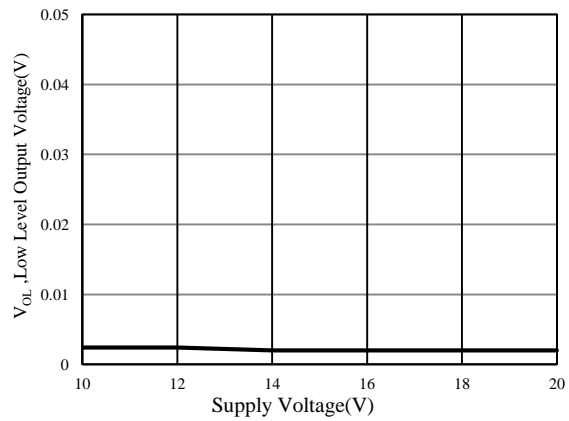


Figure 12. Low Level Output Voltage ( $I_o=2mA$ ) vs. Supply Voltage

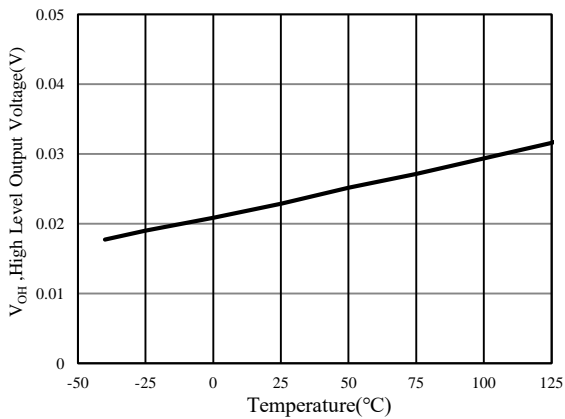


Figure 13. High Level Output Voltage ( $I_o=2mA$ ) vs. Temperature

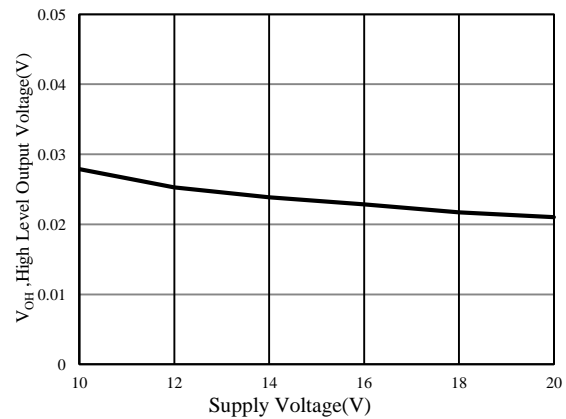


Figure 14. High Level Output Voltage ( $I_o=2mA$ ) vs. Supply Voltage

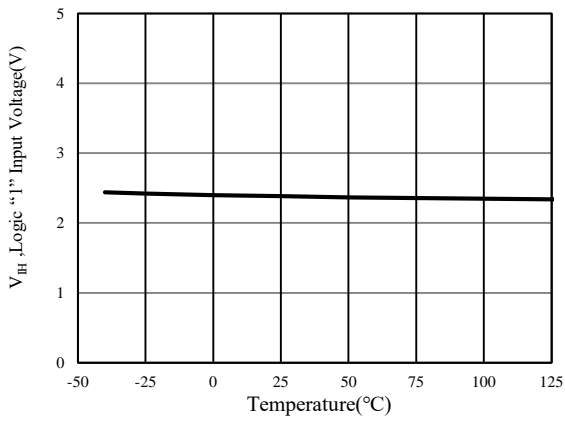


Figure 15. Logic "1" input voltage vs. Temperature

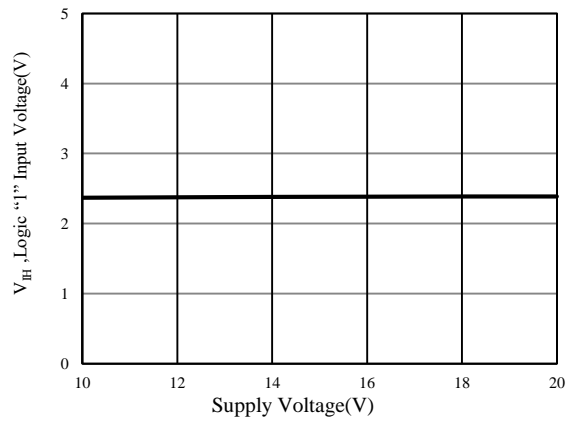


Figure 16. Logic "1" input voltage vs. Supply Voltage

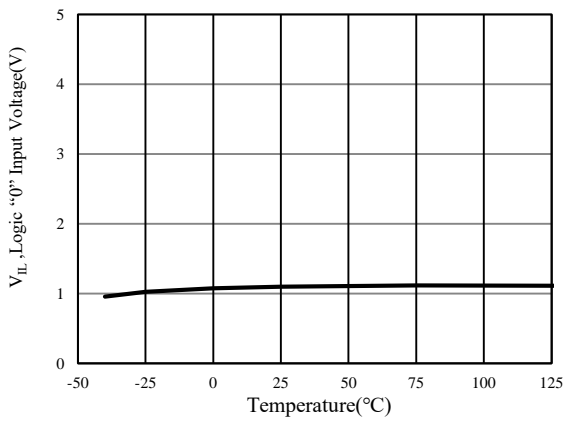


Figure 17. Logic "0" input voltage vs. Temperature

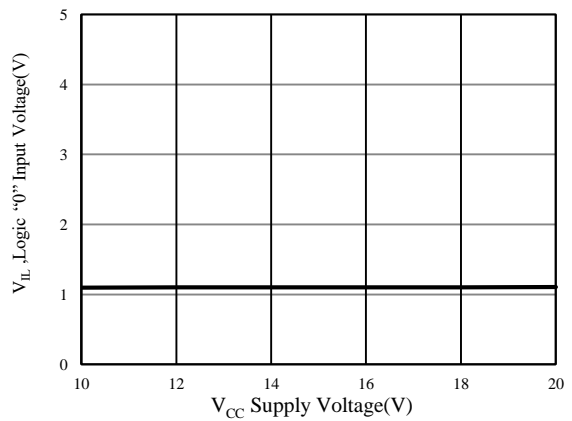


Figure 18. Logic "0" input voltage vs. Supply Voltage

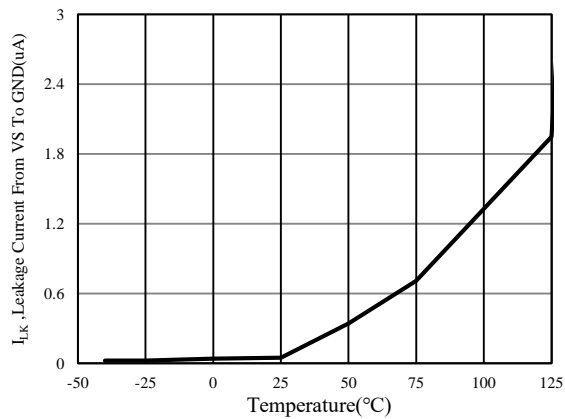


Figure 19. Leakage Current From VS(600V) To GND vs. Temperature

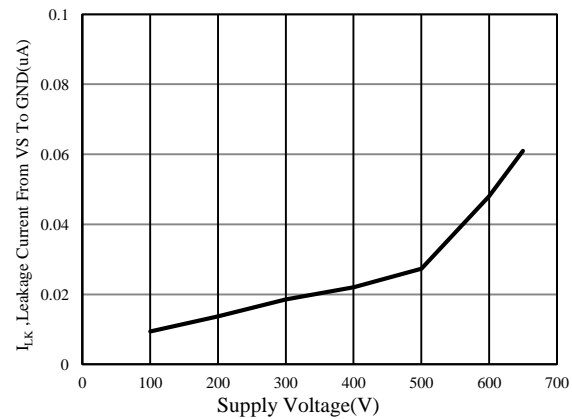


Figure 20. Leakage Current From VS To GND vs. Supply Voltage



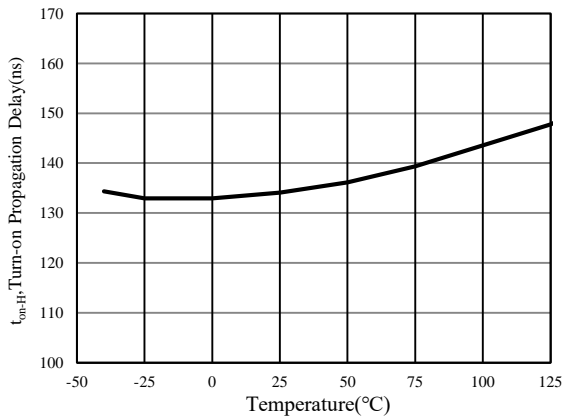


Figure 21. Turn-on Propagation Delay(HIN to HO) vs. Temperature

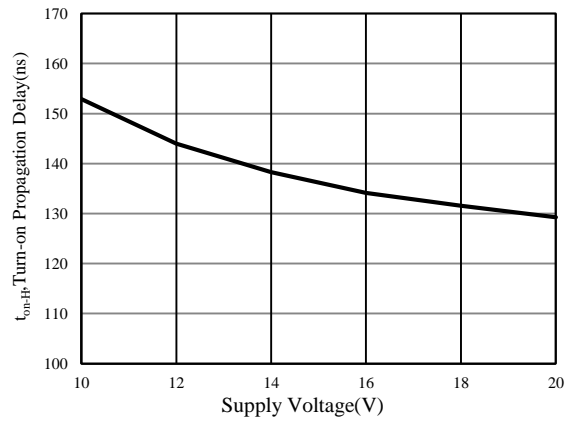


Figure 22. Turn-on Propagation Delay(HIN to HO) vs. Supply Voltage

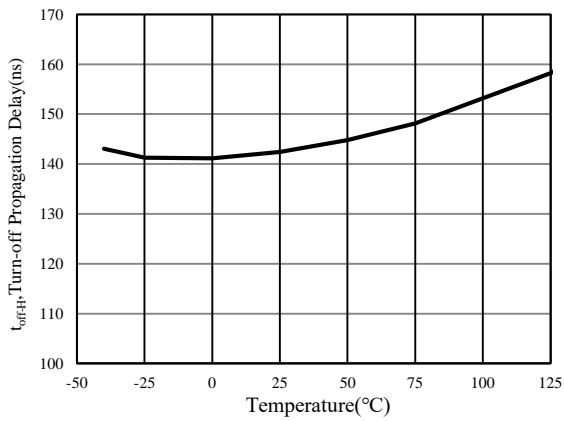


Figure 23. Turn-off Propagation Delay(HIN to HO) vs. Temperature

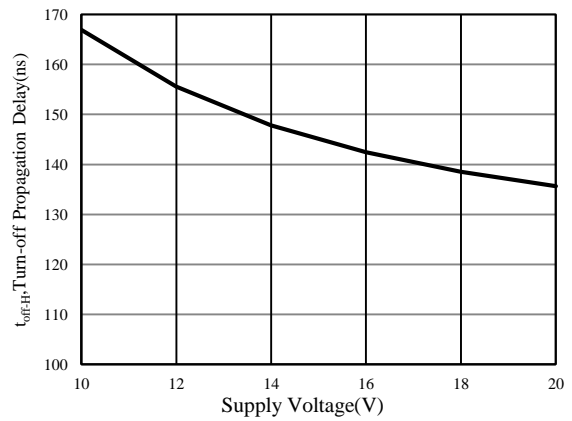


Figure 24. Turn-off Propagation Delay(HIN to HO) vs. Supply Voltage

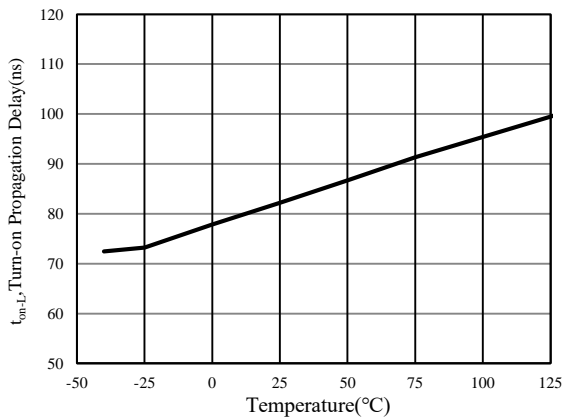


Figure 25. Turn-on Propagation Delay(LIN to LO) vs. Temperature

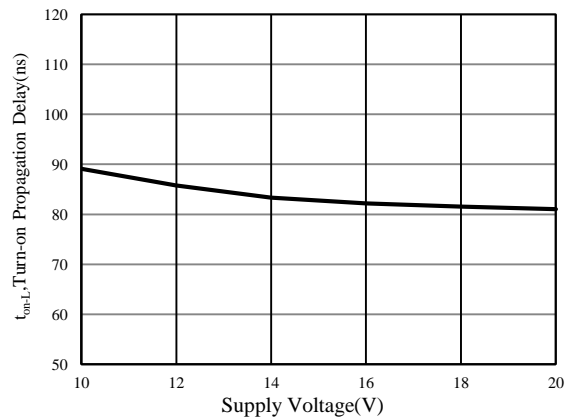


Figure 26. Turn-on Propagation Delay(LIN to LO) vs. Supply Voltage

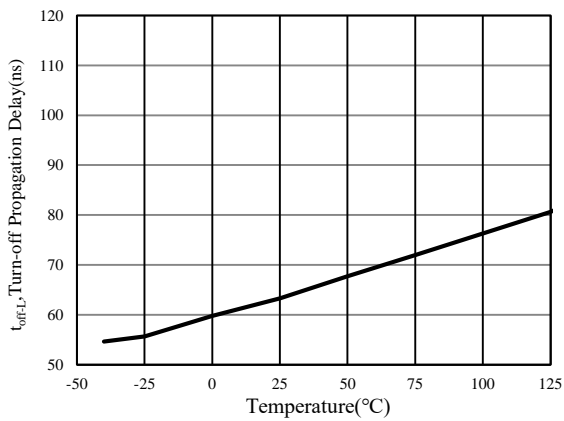


Figure 27. Turn-off Propagation Delay(LIN to LO) vs. Temperature

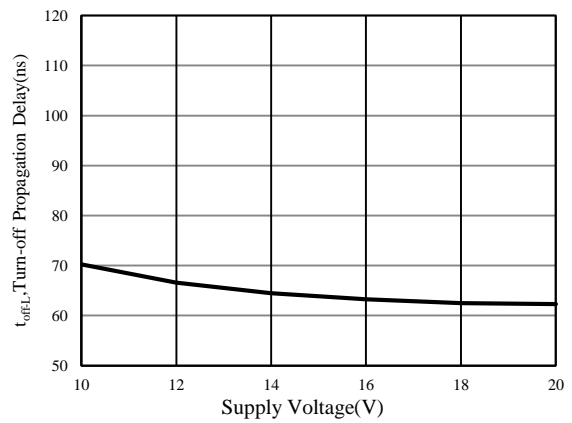


Figure 28. Turn-off Propagation Delay(LIN to LO) vs. Supply Voltage

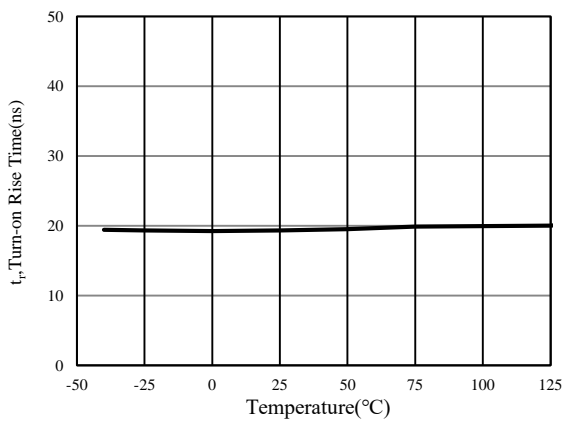


Figure 29. Turn-on Rise Time vs. Temperature

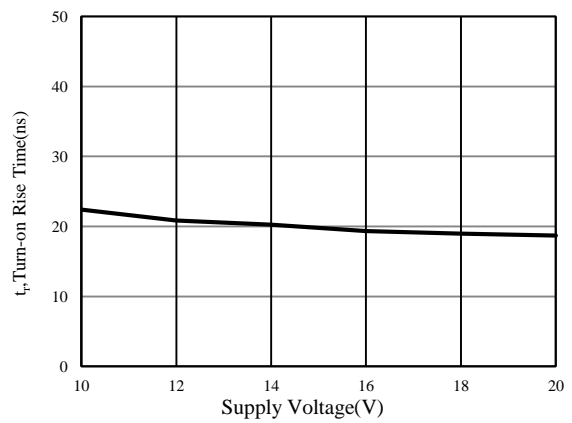


Figure 30. Turn-on Rise Time vs. Supply Voltage

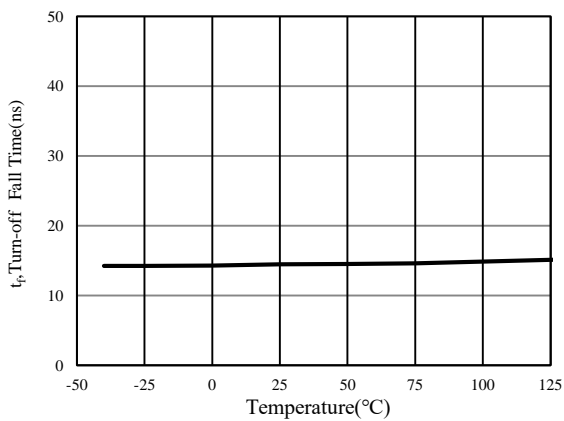


Figure 31. Turn-off Fall Time vs. Temperature

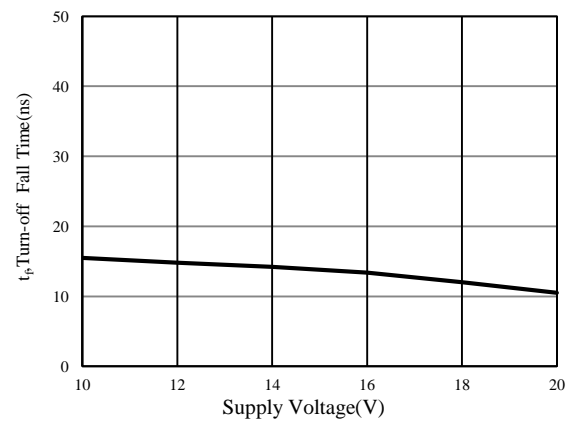


Figure 32. Turn-off Fall Time vs. Supply Voltage

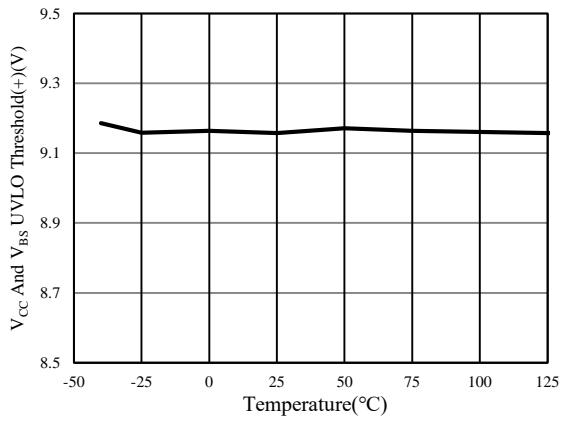


Figure 33. V<sub>CC</sub> And V<sub>BS</sub> UVLO Threshold(+) vs. Temperature

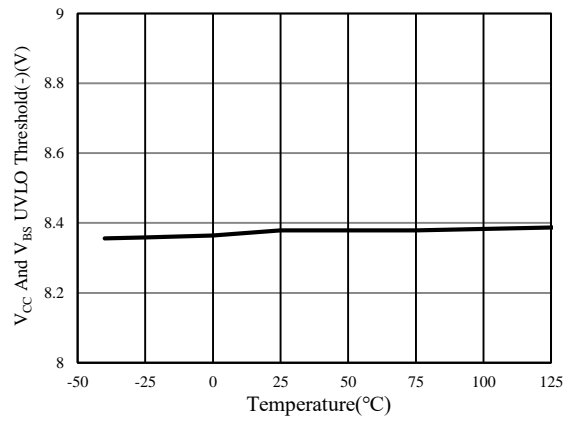


Figure 34. V<sub>CC</sub> And V<sub>BS</sub> UVLO Threshold(-) vs. Temperature

## Package Information

### Package Information SOP8

Size Symbol	Min. (mm)	Max. (mm)	Size Symbol	Min. (mm)	Max. (mm)
A	1.300	1.750	E	5.800	6.25
A1	0.000	0.250	E1	3.750	4.150
A2	1.250	1.600	e	1.27	
b	0.306	0.510	L	0.400	1.270
c	0.150	0.250	$\theta$	0°	12°
D	4.700	5.100			

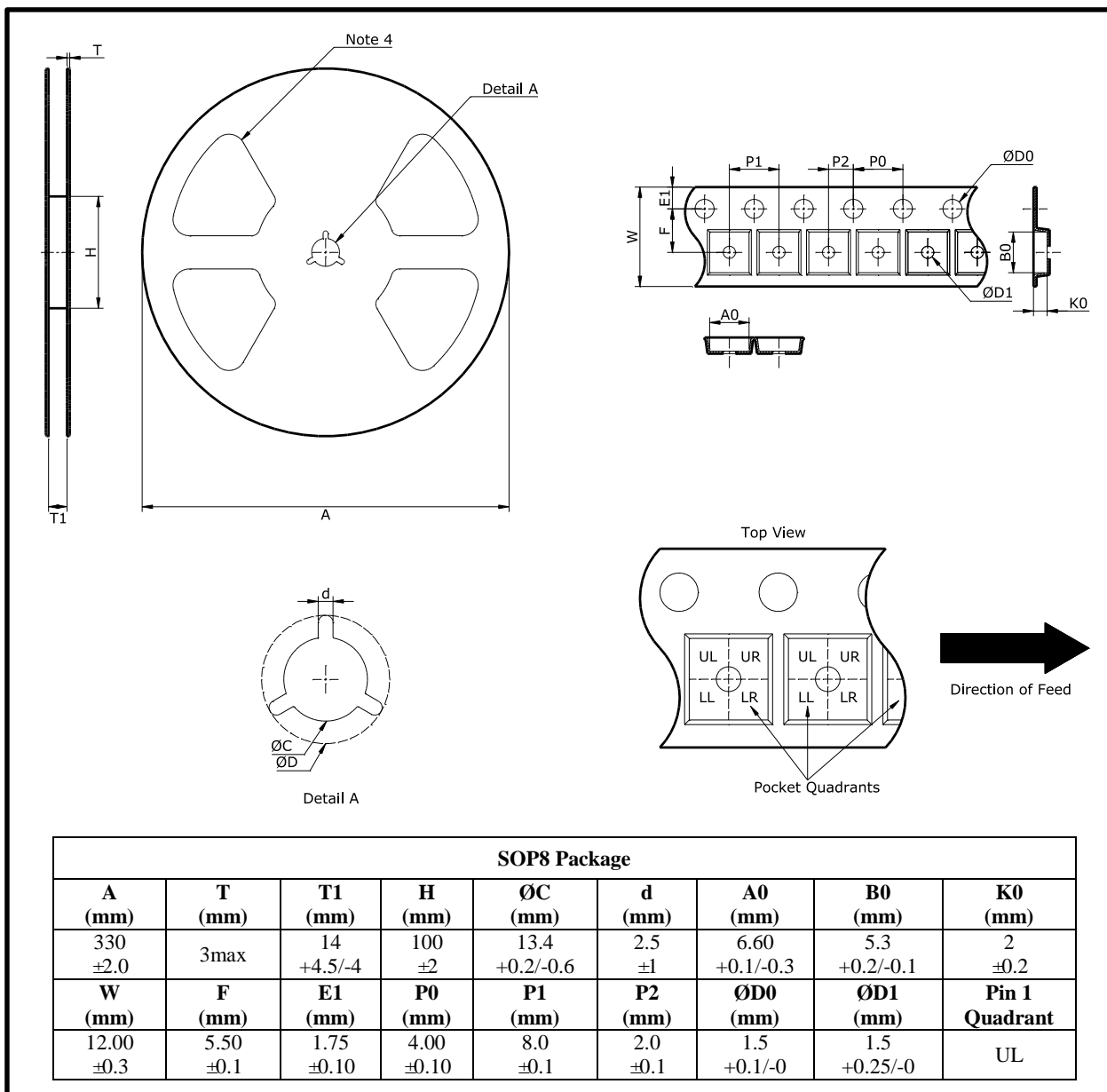
Top mark	Package
iDR. ID7186 YWWXXXXX	SOP8

Note: Y: Year Code; WW: Week Code; XXXXX: Internal Code

Notes:

1. This drawing is subjected to change without notice.
2. Body dimensions do not include mold flash or protrusion.

## Tape and Reel Information



### Notes:

1. This drawing is subjected to change without notice.
2. All dimensions are nominal and in mm.
3. This drawing is not in scale and for reference only. Customer can contact Chipown sales representative for further details.
4. The number of flange openings depends on the reel size and assembly site. This drawing shows an example only.

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